
ML610Q461/ML610Q462/ML610Q463

8-bit Microcontroller with a Built-in LCD driver

GENERAL DESCRIPTION

This LSI is a high-performance 8-bit CMOS microcontroller into which peripheral circuits, such as synchronous serial port, UART, RC oscillation type A/D converter, and LCD driver, are incorporated around LAPIS Semiconductor-original 8-bit CPU nX-U8/100. ML610Q461 operates in both high/low-speed mode and power-saving mode, it is most suitable for battery operated products.

ML610Q461P/ML610Q462P/ML610Q463P support industrial temperature -40°C to +85°C, are added to the product lineup.

FEATURES

- CPU
 - 8-bit RISC CPU (CPU name: nX-U8/100)
 - Instruction system: 16-bit instructions
 - Instruction set: Transfer, arithmetic operations, comparison, logic operations, multiplication/division, bit manipulations, bit logic operations, jump, conditional jump, call return stack manipulations, arithmetic shift, and so on
 - On-Chip debug function
 - Minimum instruction execution time
 - 30.5 μ s (@32.768 kHz system clock)
 - 2 μ s (@500kHz system clock)
 - 0.5 μ s (@2MHz system clock)

- Internal memory
 - Internal 16KByte Flash ROM (8K \times 16 bits) (including unusable 1K Byte TEST area)
 - Internal 1KByte Data RAM (1024 \times 8 bits)

- Interrupt controller
 - 1 non-maskable interrupt sources
 - Internal source: 1 (Watch dog timer)
 - 17 maskable interrupt sources
 - Internal sources: 12 (SSIO0, Timer0, Timer1, Timer2, Timer3, UART0, RC-A/D converter, PWM0, TBC128Hz, TBC32Hz, TBC16Hz, TBC2Hz)
 - External sources: 5 (P00, P01, P02, P03, P04)

- Time base counter
 - Low-speed time base counter \times 1 channel
 - Frequency compensation (Compensation range: Approx. -488ppm to +488ppm. Compensation accuracy: Approx. 0.48ppm)
 - High-speed time base counter \times 1 channel

- Watchdog timer
 - Non-maskable interrupt and reset
 - Free running
 - Overflow period: 4 types selectable (125ms, 500ms, 2s, and 8s)

- Timers
 - 8 bits × 4 channels (Timer0-3: 16-bit x 2 configuration available by using Timer0-1 or Timer2-3)
 - Clock frequency measurement mode (in one channel of 16-bit configuration using Timer2-3)
- Capture
 - Time base capture × 2 channels (4096 Hz to 32 Hz)
- PWM
 - Resolution 16 bits × 1 channel
- Synchronous serial port
 - Master/slave selectable × 1 channel
 - LSB first/MSB first selectable
 - 8-bit length/16-bit length selectable
- UART
 - Half-Duplex Communication
 - TXD/RXD × 1 channel
 - Bit length, parity/no parity, odd parity/even parity, 1 stop bit/2 stop bits
 - Positive logic/negative logic selectable
 - Built-in baud rate generator
- RC oscillation type A/D converter
 - 16-bit counter
 - Time division × 2 channels
- General-purpose ports
 - Input-only port × 5 channels (including secondary functions)
 - Output-only port
 - ML610Q461 : 10 channels (including secondary functions)
 - ML610Q462 : 6 channels (including secondary functions)
 - ML610Q463 : 2 channels (including secondary functions)
 - Input/output port × 14 channels (including secondary functions)
- LCD driver
 - The number of segments
 - ML610Q461 : 64 dots max. (16seg×4com)
 - ML610Q462 : 80 dots max. (20seg×4com)
 - ML610Q463 : 96 dots max. (24seg×4com)
 - 1/1 to 1/4 duty
 - 1/2, 1/3 bias (built-in bias generation circuit)
 - Frame frequency selectable: approx. 64Hz, 73Hz, 85Hz, and 102Hz
 - Bias voltage multiplying clock selectable (8 types)
 - LCD drive stop mode, LCD display mode, all LCDs on mode, and all LCDs off mode selectable
- Reset
 - Reset through the RESET_N pin
 - Power-on reset generation when powered on
 - Reset when oscillation stop of the low-speed clock is detected
 - Reset by the watchdog timer (WDT) overflow
- Clock
 - Low-speed clock: Crystal oscillation (32.768 kHz)
(This LSI can not guarantee the operation without low-speed crystal oscillation clock)
 - High-speed clock: Built-in RC oscillation (500 kHz, 2MHz)

- Power management
 - HALT mode: Instruction execution by CPU is suspended (peripheral circuits are in operating states).
 - STOP mode: Stop of low-speed oscillation and high-speed oscillation (Operations of CPU and peripheral circuits are stopped.)
 - High-speed Clock gear: The frequency of high-speed system clock can be changed by software (1/1, 1/2, 1/4, 1/8 of the oscillation clock)
 - Block Control Function: Resets and completely turns circuits of unused peripherals off.

- Shipment
 - Chip
 - ML610Q461-xxxWA
 - ML610Q462-xxxWA
 - ML610Q463-xxxWA
 - ML610Q461P-xxxWA
 - ML610Q462P-xxxWA
 - ML610Q463P-xxxWA
 - 64-pin plastic TQFP
 - ML610Q461-xxxTBZ0AAL
 - ML610Q462-xxxTBZ0AAL
 - ML610Q463-xxxTBZ0AAL
 - ML610Q461P-xxxTB0AAL
 - ML610Q462P-xxxTB0AAL
 - ML610Q463P-xxxTB0AAL
 - ML610Q461-xxxTBZWAAL
 - ML610Q462-xxxTBZWAAL
 - ML610Q463-xxxTBZWAAL
 - ML610Q461P-xxxTBWAAL
 - ML610Q462P-xxxTBWAAL
 - ML610Q463P-xxxTBWAAL

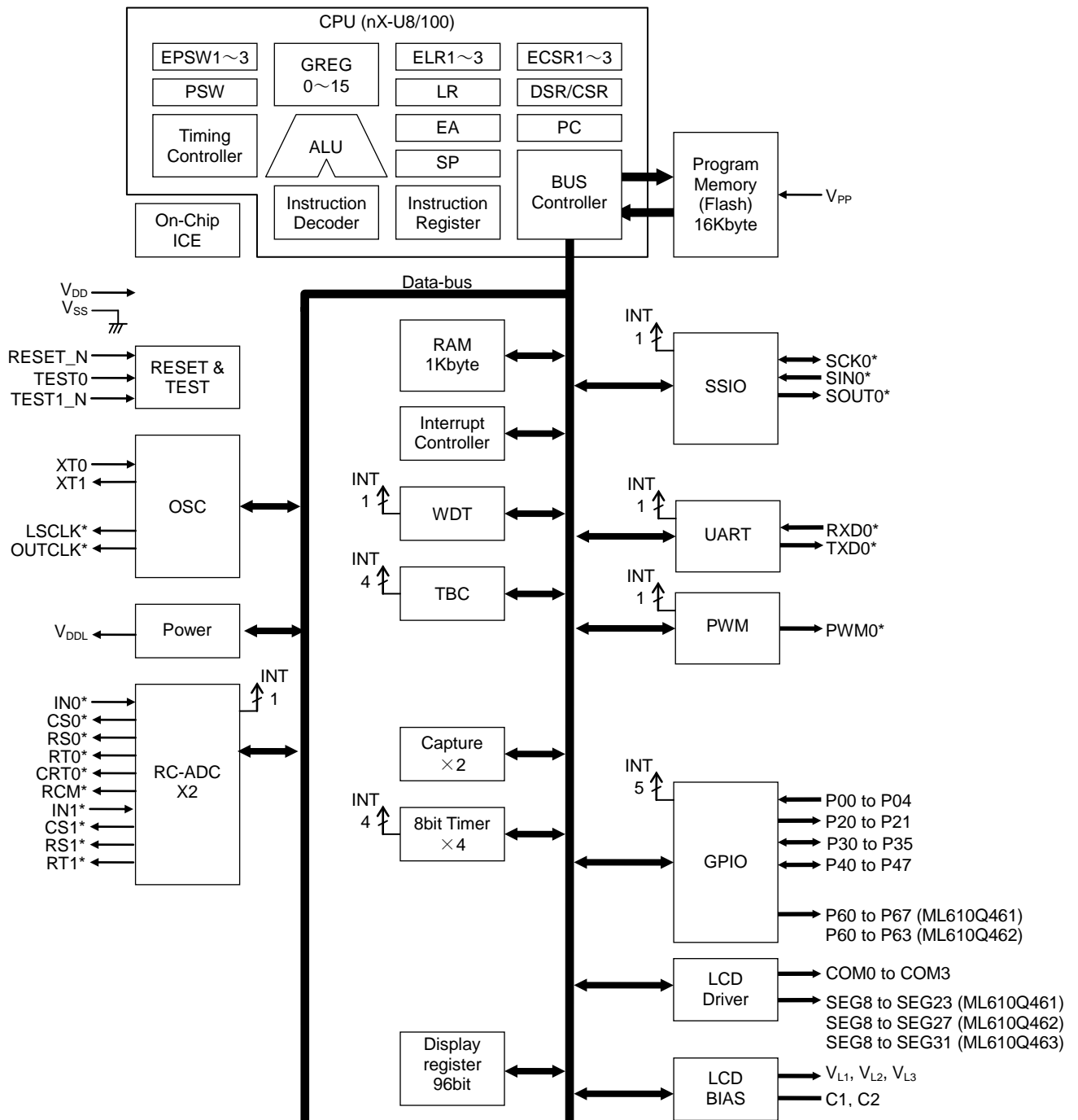
- xxx: ROM code number (xxx is NNN for blank product)
 - Q: MTP version
 - P: Wide range temperature version
 - WA: Chip
 - TBZ0AAL: TQFP (Au wire bonding),
 - TB0AAL: TQFP (Au wire bonding) (P version),
 - TBZWAAL: TQFP (Cu wire bonding),
 - TBWAAL: TQFP (Cu wire bonding) (P version)

- Guaranteed operating range
 - Operating temperature: -20°C to $+70^{\circ}\text{C}$ (P version: -40°C to $+85^{\circ}\text{C}$)
 - Operating voltage: $V_{\text{DD}} = 1.25\text{V}$ to 3.6V

BLOCK DIAGRAM

Block Diagram of ML610Q461/ML610Q462/ML610Q463

Figure 1 show the block diagram of the ML610Q461/ML610Q462/ML610Q463.

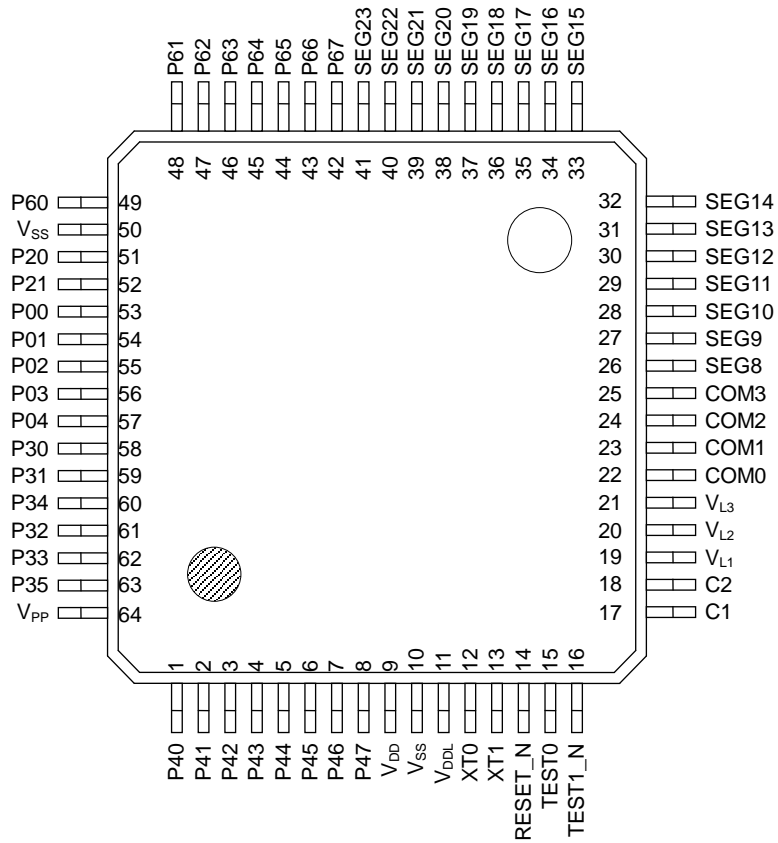


“*” indicates the secondary or tertiary function of each port.

Figure 1 ML610Q461/ML610Q462/ML610Q463 Block Diagram

PIN CONFIGURATION

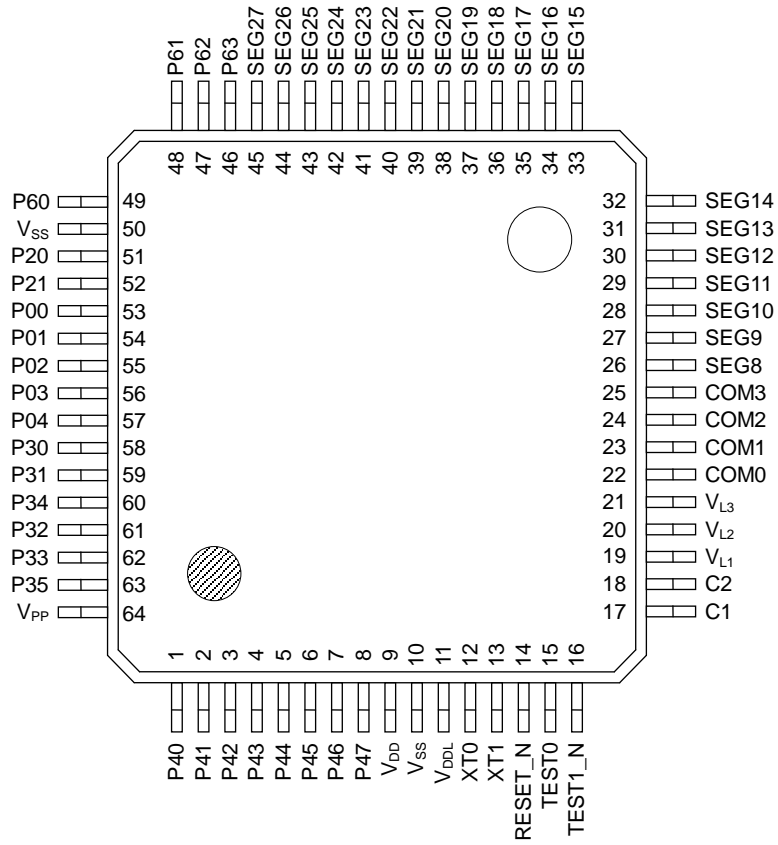
ML610Q461 TQFP64 Pin Layout



Note: The assignment of the P30 to P35 are not in order.

Figure 2 ML610Q461 TQFP64 Pin Configuration

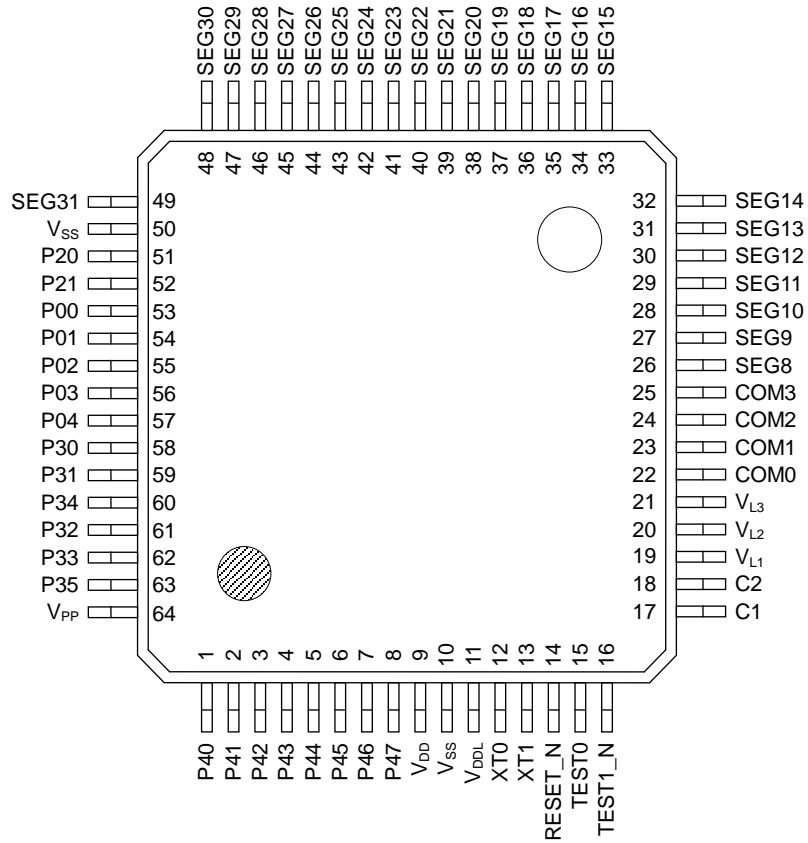
ML610Q462 TQFP64 Pin Layout



Note: The assignment of the P30 to P35 are not in order.

Figure 3 ML610Q462 TQFP64 Pin Configuration

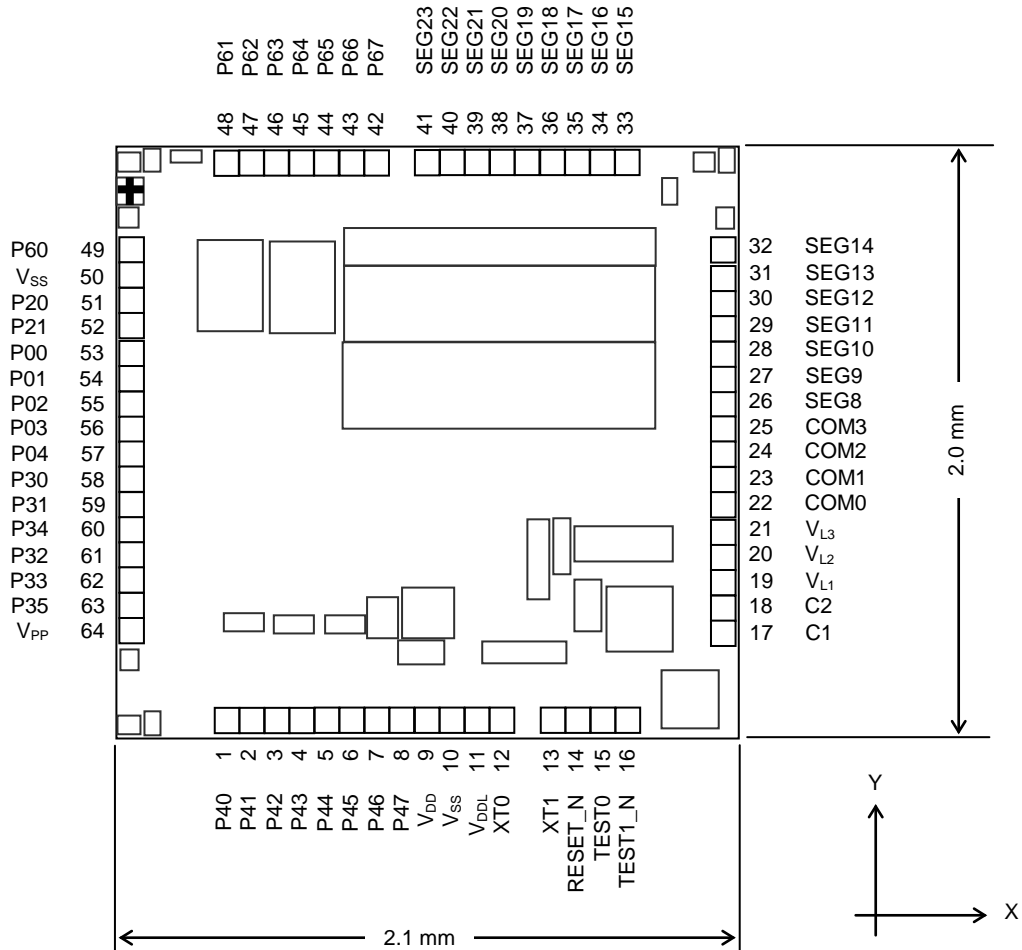
ML610Q463 TQFP64 Pin Layout



Note: The assignment of the P30 to P35 are not in order.

Figure 4 ML610Q463 TQFP64 Pin Configuration

ML610Q461 Chip Pin Layout & Dimension

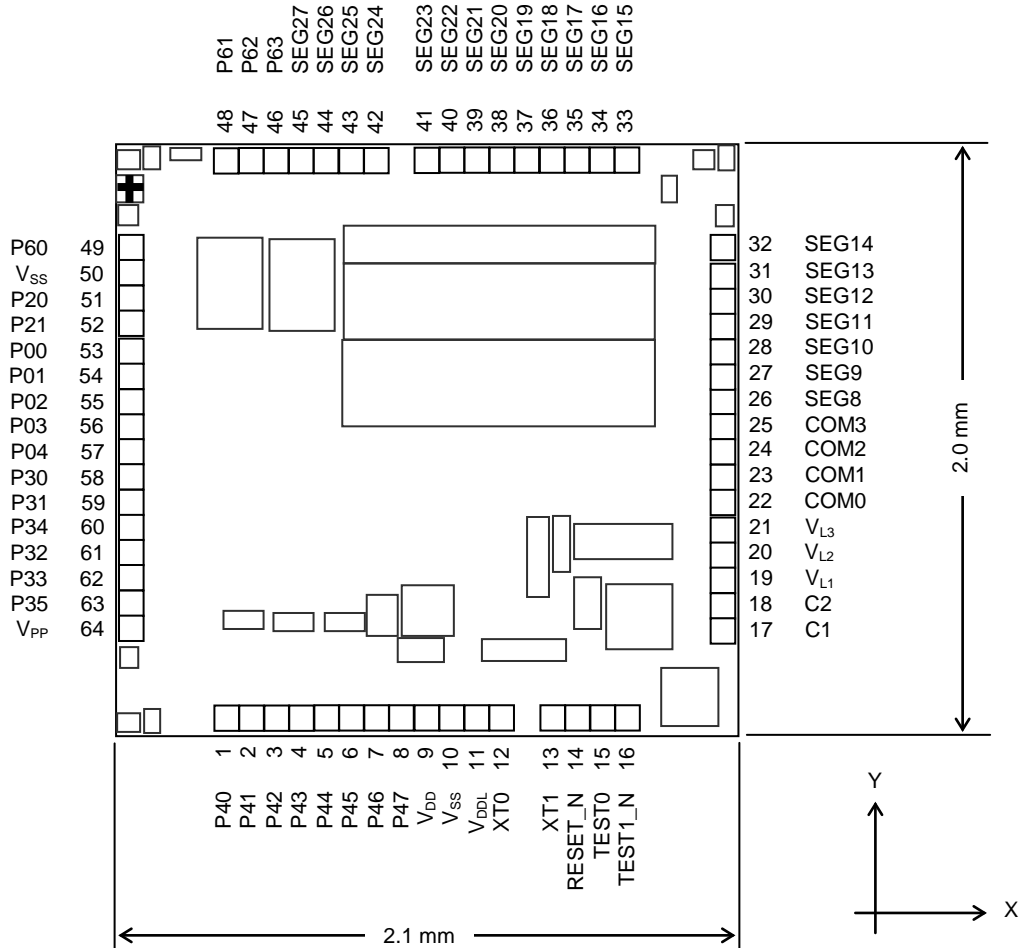


Note: The assignment of the pads P30 to P35 are not in order.

- Chip size: 2.10 mm × 2.00 mm
- PAD count: 64 pins
- Minimum PAD pitch: 80μm
- PAD aperture: 70μm×70μm
- Chip thickness: 350μm
- Voltage of the rear side of chip: V_{SS} level.

Figure 5 ML610Q461 Chip Layout & Dimension

ML610Q462 Chip Pin Layout & Dimension

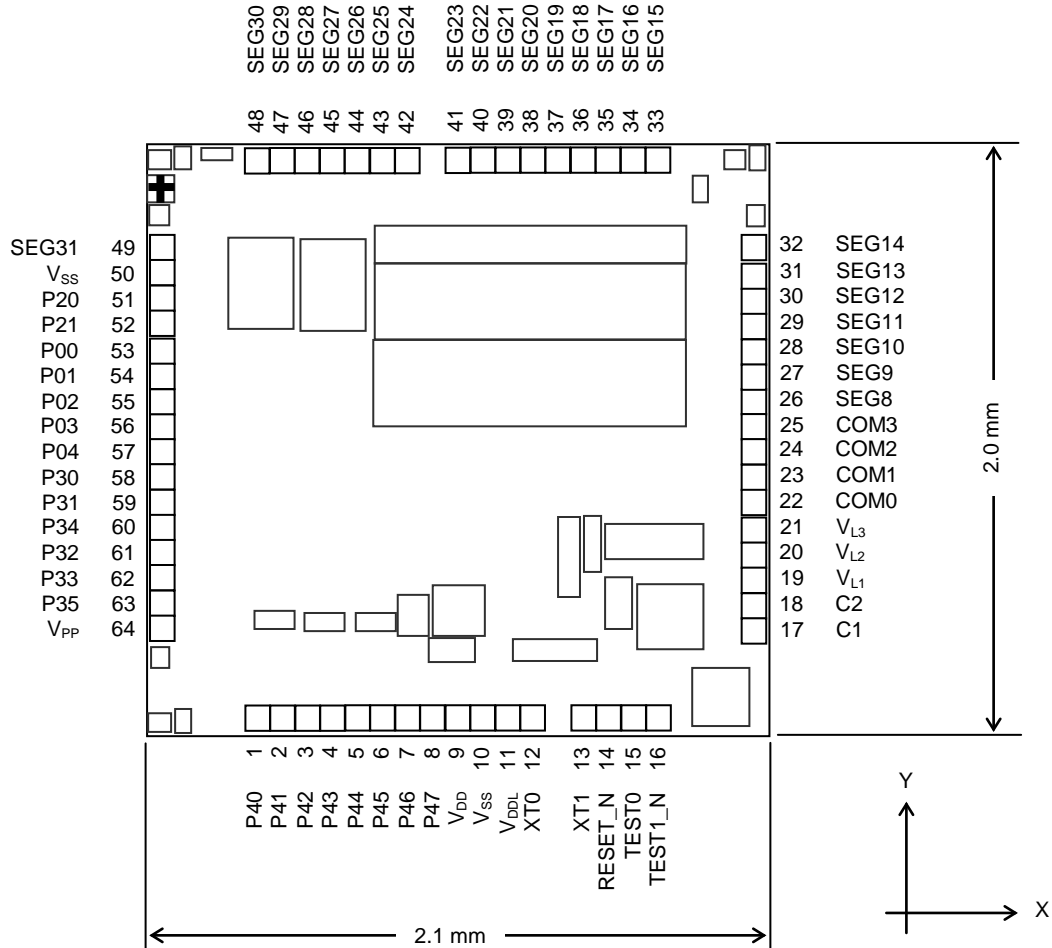


Note: The assignment of the pads P30 to P35 are not in order.

Chip size: 2.10 mm x 2.00 mm
 PAD count: 64 pins
 Minimum PAD pitch: 80µm
 PAD aperture: 70µm x 70µm
 Chip thickness: 350µm
 Voltage of the rear side of chip: VSS level.

Figure 6 ML610Q462 Chip Layout & Dimension

ML610Q463 Chip Pin Layout & Dimension



Note: The assignment of the pads P30 to P35 are not in order.

- Chip size: 2.10 mm x 2.00 mm
- PAD count: 64 pins
- Minimum PAD pitch: 80μm
- PAD aperture: 70μm x 70μm
- Chip thickness: 350μm
- Voltage of the rear side of chip: V_{SS} level.

Figure 7 ML610Q463 Chip Layout & Dimension

ML610Q461/ML610Q462/ML610Q463 Pad Coordinates

Table 1 ML610Q461/ML610Q462/ML610Q463 Pad Coordinates

Chip Center: X=0,Y=0

PAD No.	Pad Name	ML610Q461/Q462/Q463		PAD No.	Pad Name	ML610Q461/Q462/Q463	
		X (μm)	Y (μm)			X (μm)	Y (μm)
1	P40	-640	-894	42	P67 ^{(*)1}	-160	894
2	P41	-560	-894		SEG24 ^{(*)2,*)3}		
3	P42	-480	-894	43	P66 ^{(*)1}	-240	894
4	P43	-400	-894		SEG25 ^{(*)2,*)3}		
5	P44	-320	-894	44	P65 ^{(*)1}	-320	894
6	P45	-240	-894		SEG26 ^{(*)2,*)3}		
7	P46	-160	-894	45	P64 ^{(*)1}	-400	894
8	P47	-80	-894		SEG27 ^{(*)2,*)3}		
9	V _{DD}	0	-894	46	P63 ^{(*)1,*)2}	-480	894
10	V _{SS}	80	-894		SEG28 ^{(*)3}		
11	V _{DDL}	160	-894	47	P62 ^{(*)1,*)2}	-560	894
12	XT0	240	-894		SEG29 ^{(*)3}		
13	XT1	400	-894	48	P61 ^{(*)1,*)2}	-640	894
14	RESET_N	480	-894		SEG30 ^{(*)3}		
15	TEST0	560	-894	49	P60 ^{(*)1,*)2}	-944	615
16	TEST1_N	640	-894		SEG31 ^{(*)3}		
17	C1	944	-610	50	V _{SS}	-944	535
18	C2	944	-530	51	P20	-944	455
19	V _{L1}	944	-450	52	P21	-944	375
20	V _{L2}	944	-370	53	P00	-944	280
21	V _{L3}	944	-290	54	P01	-944	200
22	COM0	944	-200	55	P02	-944	120
23	COM1	944	-120	56	P03	-944	40
24	COM2	944	-40	57	P04	-944	-40
25	COM3	944	40	58	P30	-944	-120
26	SEG8	944	120	59	P31	-944	-200
27	SEG9	944	200	60	P34	-944	-280
28	SEG10	944	280	61	P32	-944	-360
29	SEG11	944	360	62	P33	-944	-440
30	SEG12	944	440	63	P35	-944	-520
31	SEG13	944	520	64	V _{PP}	-944	-600
32	SEG14	944	615				
33	SEG15	640	894				
34	SEG16	560	894				
35	SEG17	480	894				
36	SEG18	400	894				
37	SEG19	320	894				
38	SEG20	240	894				
39	SEG21	160	894				
40	SEG22	80	894				
41	SEG23	0	894				

(*)1 Pad for ML610Q461. (*)2 Pad for ML610Q462. (*)3 Pad for ML610Q463.

PIN LIST

PIN No.	PAD No.	Primary function			Secondary function or Tertiary function			
		Pin name	I/O	Function	Secondary /Tertiary	Pin name	I/O	Function
10 50	10, 50	V _{SS}	—	Negative power supply pin	—	—	—	—
9	9	V _{DD}	—	Positive power supply pin	—	—	—	—
11	11	V _{DDL}	—	Power supply pin for internal logic (internally generated)	—	—	—	—
64	64	V _{PP}	—	Power supply pin for Flash ROM	—	—	—	—
19	19	V _{L1}	—	Power supply pin for LCD bias (internally generated or connected to positive power supply pin) ^(c1)	—	—	—	—
20	20	V _{L2}	—	Power supply pin for LCD bias (internally generated or connected to positive power supply pin) ^(c1)	—	—	—	—
21	21	V _{L3}	—	Power supply pin for LCD bias (internally generated)	—	—	—	—
17	17	C1	—	Capacitor connection pin for LCD bias generation	—	—	—	—
18	18	C2	—	Capacitor connection pin for LCD bias generation	—	—	—	—
15	15	TEST0	I/O	Test pin	—	—	—	—
16	16	TEST1_N	I	Test pin	—	—	—	—
14	14	RESET_N	I	Reset input pin	—	—	—	—
12	12	XT0	I	Low-speed clock oscillation pin	—	—	—	—
13	13	XT1	O	Low-speed clock oscillation pin	—	—	—	—
53	53	P00/EXI0/ CAPO	I	Input port, External interrupt, Capture 0 input	—	—	—	—
54	54	P01/EXI1/ CAP1	I	Input port, External interrupt, Capture 1 input	—	—	—	—
55	55	P02/EXI2/ RXD0	I	Input port, External interrupt, UART0 received data	—	—	—	—
56	56	P03/EXI3	I	Input port, External interrupt	—	—	—	—
57	57	P04/EXI4/ T02P0CK	I	Input port, Timer 0/Timer 2/PWM0 external clock input External interrupt	—	—	—	—
51	51	P20/LED0	O	Output port	Secondary	LSCLK	O	Low-speed clock output
52	52	P21/LED1	O	Output port	Secondary	OUTCLK	O	High-speed clock output
58	58	P30	I/O	Input/output port	Secondary	IN0	I	RC type ADC0 oscillation input pin
59	59	P31	I/O	Input/output port	Secondary	CS0	O	RC type ADC0 reference capacitor connection pin
60	60	P34	I/O	Input/output port	Secondary	RCT0	O	RC type ADC0 resistor/capacitor sensor connection pin
61	61	P32	I/O	Input/output port	Secondary	RS0	O	RC type ADC0 reference resistor connection pin
62	62	P33	I/O	Input/output port	Secondary	RT0	O	RC type ADC0 measurement resistor sensor connection pin
63	63	P35	I/O	Input/output port	Secondary	RCM	O	RC type ADC oscillation monitor

PIN No.	PAD No.	Primary function			Secondary function or Tertiary function			
		Pin name	I/O	Function	Secondary /Tertiary	Pin name	I/O	Function
1	1	P40	I/O	Input/output port	Secondary	—	—	—
					Tertiary	SIN0	I	SSIO0 data input
2	2	P41	I/O	Input/output port	Secondary	—	—	—
					Tertiary	SCK0	I/O	SSIO0 synchronous clock input/output
3	3	P42	I/O	Input/output port	Secondary	RXD0	I	UART data input
					Tertiary	SOUT0	O	SSIO0 data output
4	4	P43	I/O	Input/output port	Secondary	TXD0	O	UART data output
					Tertiary	PWM0	O	PWM0 output
5	5	P44/ T02P0CK	I/O	Input/output port, Timer 0/Timer 2/PWM0 external clock input	Secondary	IN1	I	RC type ADC1 oscillation input pin
					Tertiary	SIN0	I	SSIO0 data input
6	6	P45/T13CK	I/O	Input/output port, Timer 1/Timer 3 external clock input	Secondary	CS1	O	RC type ADC1 reference capacitor connection pin
					Tertiary	SCK0	I/O	SSIO0 synchronous clock input/output
7	7	P46	I/O	Input/output port	Secondary	RS1	O	RC type ADC1 reference resistor connection pin
					Tertiary	SOUT0	O	SSIO0 data output
8	8	P47	I/O	Input/output port	Secondary	RT1	O	RC type ADC1 measurement resistor sensor connection pin

PIN No.	PAD No.	Primary function			Secondary function or Tertiary function			
		Pin name	I/O	Function	Secondary/Tertiary	Pin name	I/O	Function
22	22	COM0	O	LCD common pin	—	—	—	—
23	23	COM1	O	LCD common pin	—	—	—	—
24	24	COM2	O	LCD common pin	—	—	—	—
25	25	COM3	O	LCD common pin	—	—	—	—
26	26	SEG8	O	LCD segment pin	—	—	—	—
27	27	SEG9	O	LCD segment pin	—	—	—	—
28	28	SEG10	O	LCD segment pin	—	—	—	—
29	29	SEG11	O	LCD segment pin	—	—	—	—
30	30	SEG12	O	LCD segment pin	—	—	—	—
31	31	SEG13	O	LCD segment pin	—	—	—	—
32	32	SEG14	O	LCD segment pin	—	—	—	—
33	33	SEG15	O	LCD segment pin	—	—	—	—
34	34	SEG16	O	LCD segment pin	—	—	—	—
35	35	SEG17	O	LCD segment pin	—	—	—	—
36	36	SEG18	O	LCD segment pin	—	—	—	—
37	37	SEG19	O	LCD segment pin	—	—	—	—
38	38	SEG20	O	LCD segment pin	—	—	—	—
39	39	SEG21	O	LCD segment pin	—	—	—	—
40	40	SEG22	O	LCD segment pin	—	—	—	—
41	41	SEG23	O	LCD segment pin	—	—	—	—
42	42	P67 ⁽²⁾	O	Output port	—	—	—	—
		SEG24 ⁽³⁾⁽⁴⁾	O	LCD segment pin	—	—	—	—
43	43	P66 ⁽²⁾	O	Output port	—	—	—	—
		SEG25 ⁽³⁾⁽⁴⁾	O	LCD segment pin	—	—	—	—
44	44	P65 ⁽²⁾	O	Output port	—	—	—	—
		SEG26 ⁽³⁾⁽⁴⁾	O	LCD segment pin	—	—	—	—
45	45	P64 ⁽²⁾	O	Output port	—	—	—	—
		SEG27 ⁽³⁾⁽⁴⁾	O	LCD segment pin	—	—	—	—
46	46	P63 ⁽²⁾⁽³⁾	O	Output port	—	—	—	—
		SEG28 ⁽⁴⁾	O	LCD segment pin	—	—	—	—
47	47	P62 ⁽²⁾⁽³⁾	O	Output port	—	—	—	—
		SEG29 ⁽⁴⁾	O	LCD segment pin	—	—	—	—
48	48	P61 ⁽²⁾⁽³⁾	O	Output port	—	—	—	—
		SEG30 ⁽⁴⁾	O	LCD segment pin	—	—	—	—
49	49	P60 ⁽²⁾⁽³⁾	O	Output port	—	—	—	—
		SEG31 ⁽⁴⁾	O	LCD segment pin	—	—	—	—

(*) Internally generated, or connect to either positive power supply pin (V_{DD}) or power supply pin for internal logic (V_{DDL}). For details, see “Chapter 20 LCD Drivers. In the user’s manual”

(*) Pad for ML610Q461. (*) Pad for ML610Q462. (*) Pad for ML610Q463.

PIN DESCRIPTION

Pin name	I/O	Description	Primary/ Secondary/ Tertiary	Logic
System				
RESET_N	I	Reset input pin. When this pin is set to a “L” level, system reset mode is set and the internal section is initialized. When this pin is set to a “H” level subsequently, program execution starts. A pull-up resistor is internally connected.	—	Negative
XT0	I	Crystal connection pin for low-speed clock.	—	—
XT1	O	A 32.768 kHz crystal oscillator (see measuring circuit 1) is connected to this pin. Capacitors CDL and CGL are connected across this pin and V _{SS} .	—	—
LSCLK	O	Low-speed clock output pin. This pin is used as the secondary function of the P20 pin.	Secondary	—
OUTCLK	O	High-speed clock output pin. This pin is used as the secondary function of the P21 pin.	Secondary	—
General-purpose input port				
P00-P04	I	General-purpose input port. Since these pins have secondary functions, the pins cannot be used as a port when the secondary functions are used.	Primary	Positive
General-purpose output port				
P20-P21	O	General-purpose output port. Since these pins have secondary functions, the pins cannot be used as a port when the secondary functions are used.	Primary	Positive
General-purpose input/output port				
P30-P35	I/O	General-purpose input/output port. Since these pins have secondary functions, the pins cannot be used as a port when the secondary functions are used.	Primary	Positive
P40-P47	I/O	General-purpose input/output port. Since these pins have secondary functions, the pins cannot be used as a port when the secondary functions are used.	Primary	Positive
P60-P63	O	General-purpose output port Incorporated only into ML610Q461/ML610Q462, and not into ML610Q463.	Primary	Positive
P64-P67	O	General-purpose output port Incorporated only into ML610Q461, and not into ML610Q462/ ML610Q463.	Primary	Positive

Pin name	I/O	Description	Primary/ Secondary/ Tertiary	Logic
UART				
TXD0	O	UART data output pin. This pin is used as the secondary function of the P43 pin.	Secondary	Positive
RXD0	I	UART data input pin. This pin is used as the secondary function of the P42 or the primary function of the P02 pin.	Primary/ Secondary	Positive
Synchronous serial (SSIO)				
SCK0	I/O	Synchronous serial clock input/output pin. This pin is used as the tertiary function of the P41 or P45 pin.	Tertiary	—
SIN0	I	Synchronous serial data input pin. This pin is used as the tertiary function of the P40 or P44 pin.	Tertiary	Positive
SOUT0	O	Synchronous serial data output pin. This pin is used as the tertiary function of the P42 or P46 pin.	Tertiary	Positive
PWM				
PWM0	O	PWM0 output pin. This pin is used as the tertiary function of the P43 or P34 pin.	Tertiary	Positive
External interrupt				
EXI0-4	I	External maskable interrupt input pins. Interrupt enable and edge selection can be performed for each bit by software. These pins are used as the primary functions of the P00-P04 pins.	Primary	Positive/ negative
Capture				
CAP0	I	Capture trigger input pins. The value of the time base counter is captured in the register synchronously with the interrupt edge selected by software.	Primary	Positive/ negative
CAP1	I	These pins are used as the primary functions of the P00 pin(CAP0) and P01 pin(CAP1).	Primary	Positive/ negative
LED drive				
LED0-1	O	Nch open drain output pins to drive LED.	Primary	Positive/ negative

Pin name	I/O	Description	Primary/ Secondary/ Tertiary	Logic
RC oscillation type A/D converter				
IN0	I	Channel 0 oscillation input pin. This pin is used as the secondary function of the P30 pin.	Secondary	—
CS0	O	Channel 0 reference capacitor connection pin. This pin is used as the secondary function of the P31 pin.	Secondary	—
RCT0	O	Resistor/capacitor sensor connection pin of Channel 0 for measurement. This pin is used as the secondary function of the P33 pin.	Secondary	—
RS0	O	This pin is used as the secondary function of the P32 pin which is the reference resistor connection pin of Channel 0.	Secondary	—
RT0	O	Resistor sensor connection pin of Channel 0 for measurement. This pin is used as the secondary function of the P34 pin.	Secondary	—
RCM	O	RC oscillation monitor pin. This pin is used as the secondary function of the P35 pin.	Secondary	—
IN1	I	Oscillation input pin of Channel 1. This pin is used as the secondary function of the P44 pin.	Secondary	—
CS1	O	Reference capacitor connection pin of Channel 1. This pin is used as the secondary function of the P45 pin.	Secondary	—
RS1	O	Reference resistor connection pin of Channel 1. This pin is used as the secondary function of the P46 pin.	Secondary	—
RT1	O	Resistor sensor connection pin for measurement of Channel 1. This pin is used as the secondary function of the P47 pin.	Secondary	—
LCD drive signal				
COM0-3	O	Common output pins.	—	—
SEG8-23	O	Segment output pins.	—	—
SEG24-27	O	Segment output pins. Incorporated into ML610Q462/ML610Q463, not into ML610Q461.	—	—
SEG28-31	O	Segment output pins. Incorporated into ML610Q463, not into ML610Q461/ML610Q462.	—	—
LCD driver power supply				
V _{L1}	—	Power supply pins for LCD bias (internally generated or positive power supply pin connected). Depending on LCD Bias setting and V _{DD} voltage level, V _{DD} or V _{DDL} or capacitor is connected. For details of the connection method, see user's manual.	—	—
V _{L2}	—		—	—
V _{L3}	—		—	—
C1	—	Power supply pins for LCD bias (internally generated). Capacitors C12 is connected between C1 and C2.	—	—
C2	—		—	—
For testing				
TEST0	I/O	Input/output pin for testing. A pull-down resistor is internally connected.	—	—
TEST1_N	I	Input pin for testing. A pull-up resistor is internally connected.	—	—
Power supply				
V _{SS}	—	Negative power supply pin.	—	—
V _{DD}	—	Positive power supply pin for I/O, internal regulator, battery low detector, and power-on reset.	—	—
V _{DDL}	—	Positive power supply pin (internally generated) for internal logic. Capacitor CL (see measuring circuit 1) is connected between this pin and V _{SS} .	—	—
V _{PP}	—	Power supply pin for programming Flash ROM. A pull-down resistor is internally connected.	—	—

TERMINATION OF UNUSED PINS

Table 2 shows methods of terminating the unused pins.

Table 2 Termination of Unused Pins

Pin	Recommended pin termination
V _{PP}	Open
V _{L1} , V _{L2} , V _{L3}	Open
C1, C2	Open
RESET_N	Open
TEST0	Open
TEST1_N	Open
P00 to P04	V _{DD} or V _{SS}
P20 to P21	Open
P30 to P35	Open
P40 to P47	Open
P60 to P67	Open
COM0 to 3	Open
SEG8 to 31	Open

Note:

It is recommended to set the unused input ports and input/output ports to the inputs with pull-down resistors/pull-up resistors or the output mode since the supply current may become excessively large if the pins are left open in the high impedance input setting.

ELECTRICAL CHARACTERISTICS
ABSOLUTE MAXIMUM RATINGS

 (V_{SS} = 0V)

Parameter	Symbol	Condition	Rating	Unit
Power supply voltage 1	V _{DD}	Ta = 25°C	-0.3 to +4.6	V
Power supply voltage 2	V _{PP}	Ta = 25°C	-0.3 to +9.5	V
Power supply voltage 3	V _{DDL}	Ta = 25°C	-0.3 to +3.6	V
Power supply voltage 4	V _{L1}	Ta = 25°C	-0.3 to +2.0	V
Power supply voltage 5	V _{L2}	Ta = 25°C	-0.3 to +4.0	V
Power supply voltage 6	V _{L3}	Ta = 25°C	-0.3 to +6.0	V
Input voltage	V _{IN}	Ta = 25°C	-0.3 to V _{DD} +0.3	V
Output voltage	V _{OUT}	Ta = 25°C	-0.3 to V _{DD} +0.3	V
Output current 1	I _{OUT1}	Port3-6, Ta = 25°C	-12 to +11	mA
Output current 2	I _{OUT2}	Port2, Ta = 25°C	-12 to +20	mA
Power dissipation	PD	Ta = 25°C	0.9	W
Storage temperature	T _{STG}	—	-55 to +150	°C

RECOMMENDED OPERATING CONDITIONS

 (V_{SS} = 0V)

Parameter	Symbol	Condition	Range	Unit
Operating temperature	T _{OP}	non-P version	-20 to +70	°C
		P version	-40 to +85	
Operating voltage	V _{DD}	f _{OP} = 30k to 625kHz	1.25 to 3.6	V
		f _{OP} = 30k to 2.5MHz	1.8 to 3.6	
Operating frequency (CPU)	f _{OP}	V _{DD} = 1.25 to 3.6V	30k to 625k	Hz
		V _{DD} = 1.8 to 3.6V	30k to 2.5M	
Low-speed crystal oscillation frequency	f _{XTL}	—	32.768k	Hz
Low-speed crystal oscillation external capacitor	C _{DL}	—	3 to 18	pF
	C _{GL}	—	3 to 18	
Capacitor externally connected to V _{DDL} pin	C _L	—	0.47±30%	μF
Capacitors externally connected to V _{L1, 2, 3} pins	C _{a, b, c}	—	0.1±30%	μF
Capacitors externally connected across C1 and C2 pins	C ₁₂	—	0.47±30%	μF

OPERATING CONDITIONS OF FLASH ROM

(V_{SS} = 0V)

Parameter	Symbol	Condition	Range	Unit
Operating temperature	T _{OP}	At write/erase	0 to +40	°C
Operating voltage	V _{DD}	At write/erase ^{*1}	2.75 to 3.6	V
	V _{DDL}	At write/erase ^{*1}	2.5 to 2.75	
	V _{PP}	At write/erase ^{*1}	7.7 to 8.3	
erase/program cycles	C _{EP}	—	80	cycles
Data retention	Y _{DR}	—	10	years

^{*1}: Those voltages must be supplied to V_{DDL} pin and V_{PP} pin when programming and erasing Flash ROM. V_{PP} pin has an internal pulldown resistor.

DC CHARACTERISTICS (1/5)

(V_{DD} = 1.25 to 3.6V, V_{SS} = 0V, Ta = -20 to +70°C, Ta = -40 to +85°C for P version, unless otherwise specified)

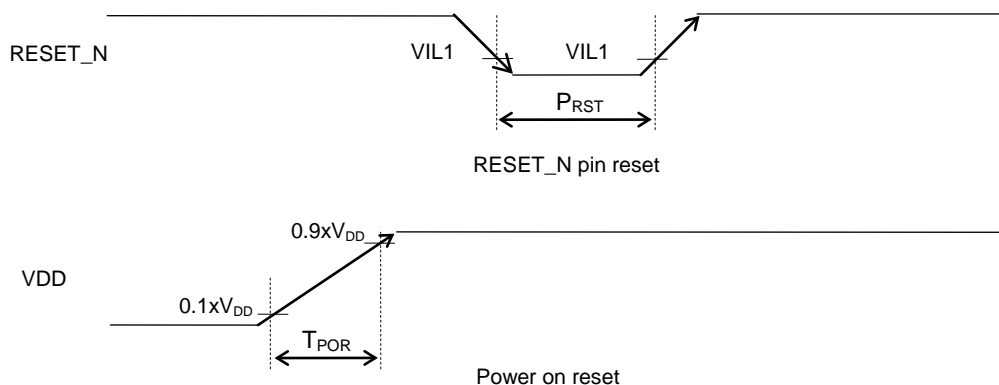
Parameter	Symbol	Condition	Rating			Unit	Measuring circuit
			Min.	Typ.	Max.		
500kHz/2MHz RC oscillation frequency	f _{RC}	V _{DD} = 1.25 to 3.6V	Ta = 25°C	Typ. -10%	500	Typ. +10%	kHz
			*3	Typ. -25%	500	Typ. +25%	
		V _{DD} = 1.80 to 3.6V	Ta = 25°C	Typ. -10%	2.0	Typ. +10%	MHz
			*3	Typ. -25%	2.0	Typ. +25%	
Low-speed crystal oscillation start time ^{*2}	T _{XTL}	—	—	0.6	2	s	1
500kHz/2MHz RC oscillation start time	T _{RC}	—	—	—	0.3	μs	
Low-speed oscillation stop detect time ^{*1}	T _{STOP}	—	12	16.4	41	ms	
Reset pulse width	P _{RST}	—	200	—	—	μs	
Reset noise elimination pulse width	P _{NRST}	—	—	—	0.3		
Power-on reset activation power rise time	T _{POR}	—	—	—	10	ms	

^{*1}: When low-speed crystal oscillation stops for a duration more than the low-speed oscillation stop detect time, the system is reset to shift to system reset mode.

^{*2}: Use 32.768KHz Crystal resonator DT-26 (Load capacitance 6pF) (made by KDS:DAISHINKU CORP.) is used (C_{GL}=C_{DL}=12pF).

^{*3}: Recommended operating temperature (Ta = -20 to +70°C, Ta = -40 to +85°C for P version)

RESET



DC CHARACTERISTICS (2/5)

($V_{DD} = 1.25$ to $3.6V$, $V_{SS} = 0V$, $T_a = -20$ to $+70^{\circ}C$, $T_a = -40$ to $+85^{\circ}C$ for P version, unless otherwise specified)

Parameter	Symbol	Condition	Rating			Unit	Measuring circuit
			Min.	Typ.	Max.		
V_{DDL} voltage	V_{DDL}	$f_{OP} = 30k$ to $625kHz$	1.1	1.2	1.3		1
		$f_{OP} = 30k$ to $2.5MHz$	1.35	1.5	1.65		
V_{DDL} temperature deviation *1	ΔV_{DDL}	$V_{DD} = 3.0V$	—	-1	—	mV/°C	
V_{DDL} voltage dependency *1	ΔV_{DDL}	—	—	5	20	mV/V	

*1: V_{DDL} can not exceed V_{DD} level. The maximum V_{DDL} becomes V_{DD} level when the V_{DDL} calculated by the temperature deviation and voltage dependency is going to exceed the V_{DD} level.

DC CHARACTERISTICS (3/5)

($V_{DD} = 3.0V$, $V_{SS} = 0V$, $T_a = -20$ to $+70^\circ C$, $T_a = -40$ to $+85^\circ C$ for P version)

Parameter	Symbol	Condition	Rating			Unit	Measuring circuit	
			Min.	Typ.	Max.			
Supply current 1	IDD1	CPU: In STOP state. Low-speed/high-speed RC500kHz/2MHz oscillation: stopped.	Ta= 25°C	—	0.4	0.8	μA	1
			*5	—	—	8		
Supply current 2	IDD2	CPU: In HALT state (LTBC and WDT are Operating). ^{*3*4} High-speed 500kHz/2MHz oscillation: Stopped. LCD and BIAS circuits: Operating. ^{*6}	Ta= 25°C	—	0.9	1.8	μA	
			*5	—	—	9		
Supply current 3	IDD3	CPU: In 32.768kHz operating state. ^{*1*3} High-speed 500kHz/2MHz oscillation: Stopped. LCD and BIAS circuits: Operating. ^{*2}	Ta= 25°C	—	5	8	μA	
			*5	—	—	15		
Supply current 4-1	IDD4-1	CPU: In RC 500kHz operating state. LCD and BIAS circuits: Operating. ^{*2}	Ta= 25°C	—	70	100	μA	
			*5	—	—	120		
Supply current 4-2	IDD4-2	CPU: In RC 2MHz operating state. LCD and BIAS circuits: Operating. ^{*2}	Ta= 25°C	—	280	350	μA	
			*5	—	—	400		

*1: When the CPU operating rate is 100% (No HALT state).

*2: All SEGs: off waveform, No LCD panel load, 1/3 bias, 1/3 duty, Frame frequency: Approx. 64 Hz, Bias voltage multiplying clock: 1/128 LSCLK (256Hz)

*3: Use 32.768KHz Crystal resonator DT-26 (Load capacitance 6pF) (made by KDS:DAISHINKU CORP.) is used ($C_{GL}=C_{DL}=6pF$)

*4: Significant bits of BLKCON0~BLKCON4 registers except DLCD bit on BLKCON4 are all "1".

*5: Recommended operating temperature ($T_a = -20$ to $+70^\circ C$, $T_a = -40$ to $+85^\circ C$ for P version)

*6: LCD Stop mode, 1/3 bias, Bias voltage multiplying clock: 1/128 LSCLK (256Hz)

DC CHARACTERISTICS (4/5)

($V_{DD} = 1.25$ to $3.6V$, $V_{SS} = 0V$, $T_a = -20$ to $+70^{\circ}C$, $T_a = -40$ to $+85^{\circ}C$ for P version, unless otherwise specified)

Parameter	Symbol	Condition	Rating			Unit	Measuring circuit		
			Min.	Typ.	Max.				
Output voltage 1 (P20–P21 Nch open drain mode is Not selected) (P30–P35) (P40–P47) (P60–P67)	VOH1	$I_{OH1} = -0.5mA$, $V_{DD} = 1.8$ to $3.6V$	V_{DD} -0.5	—	—	V	2		
		$I_{OH1} = -0.03mA$, $V_{DD} = 1.25$ to $3.6V$	V_{DD} -0.3	—	—				
	VOL1	$I_{OL1} = +0.5mA$, $V_{DD} = 1.8$ to $3.6V$	—	—	0.5				
		$I_{OL1} = +0.1mA$, $V_{DD} = 1.25$ to $3.6V$	—	—	0.3				
Output voltage 2 (P20–P21 Nch open drain mode is selected)	VOL2	$I_{OL2} = +5mA$, $V_{DD} = 1.8$ to $3.6V$	—	—	0.5			V	2
Output voltage 3 (COM0–3) (SEG8–31)	VOH3	$I_{OH4} = -0.05mA$, $V_{L1}=1.2V$	V_{L3} -0.2	—	—				
	VOML3	$I_{OMH4} = +0.05mA$, $V_{L1}=1.2V$	—	—	V_{L2} +0.2				
	VOML3S	$I_{OM4S} = -0.05mA$, $V_{L1}=1.2V$	V_{L2} -0.2	—	—				
	VOLM3	$I_{OML4} = +0.05mA$, $V_{L1}=1.2V$	—	—	V_{L1} +0.2				
	VOLM3S	$I_{OML4S} = -0.05mA$, $V_{L1}=1.2V$	V_{L1} -0.2	—	—				
VOL3	$I_{OL4} = +0.05mA$, $V_{L1}=1.2V$	—	—	0.2					
Output leakage (P20–P21) (P30–P35) (P40–P47) (P60–P67)	IOOH	$V_{OH} = V_{DD}$ (in high-impedance state)	—	—	1	μA	3		
	IOOL	$V_{OL} = V_{SS}$ (in high-impedance state)	-1	—	—				
Input current 1 (RESET_N, TEST1_N)	IIH1	$V_{IH1} = V_{DD}$	0	—	1	μA	4		
	IIL1	$V_{IL1} = V_{SS}$	-600	-300	-2				
Input current 2 (TEST0)	IIH2	$V_{IH1} = V_{DD}$	2	300	600				
	IIL2	$V_{IL1} = V_{SS}$	-1	—	—				
Input current 3 (P00–P04) (P30–P35) (P40–P47)	IIH3	$V_{IH3} = V_{DD}$, $V_{DD} = 1.8$ to $3.6V$ (when pulled-down)	2	30	200				
		$V_{IH3} = V_{DD}$, $V_{DD} = 1.25$ to $3.6V$ (when pulled-down)							
	IIL3	$V_{IL3} = V_{SS}$, $V_{DD} = 1.8$ to $3.6V$ (when pulled-up)	-200	-30	-2				
		$V_{IL3} = V_{SS}$, $V_{DD} = 1.25$ to $3.6V$ (when pulled-up)	-200	-30	-0.01				
	IIH3Z	$V_{IH3} = V_{DD}$ (in high-impedance state)	—	—	1				
IIL3Z	$V_{IL3} = V_{SS}$ (in high-impedance state)	-1	—	—					

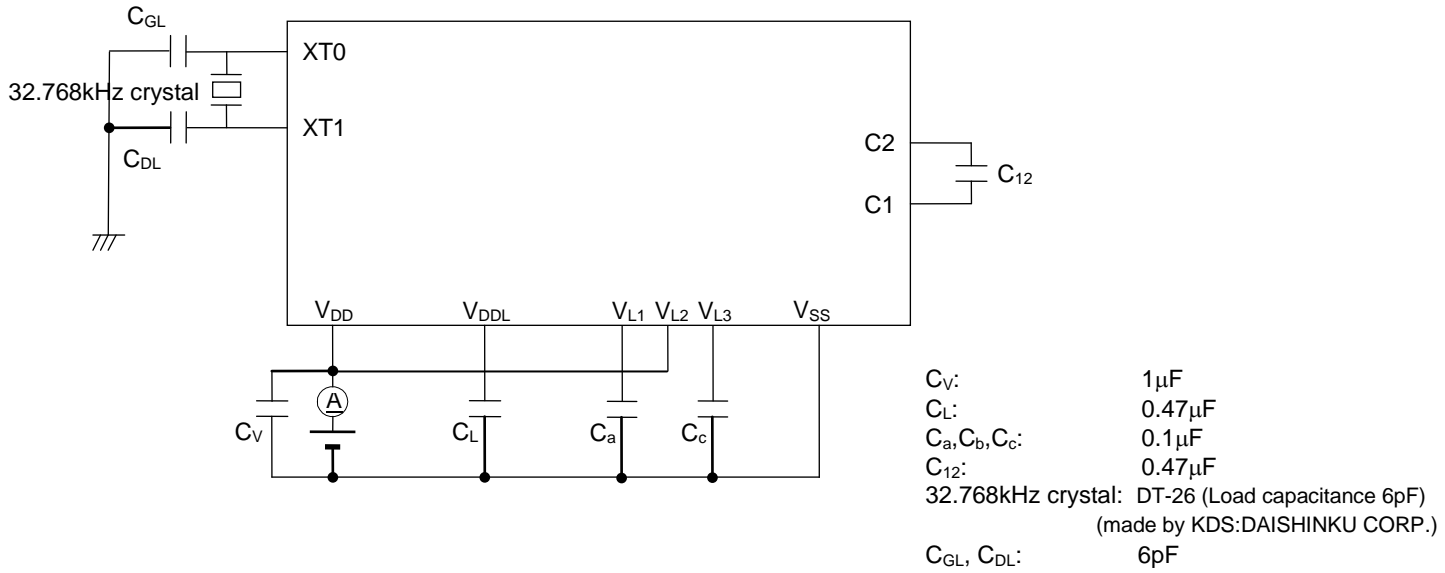
DC CHARACTERISTICS (5/5)

($V_{DD} = 1.25$ to $3.6V$, $V_{SS} = 0V$, $T_a = -20$ to $+70^{\circ}C$, $T_a = -40$ to $+85^{\circ}C$ for P version, unless otherwise specified)

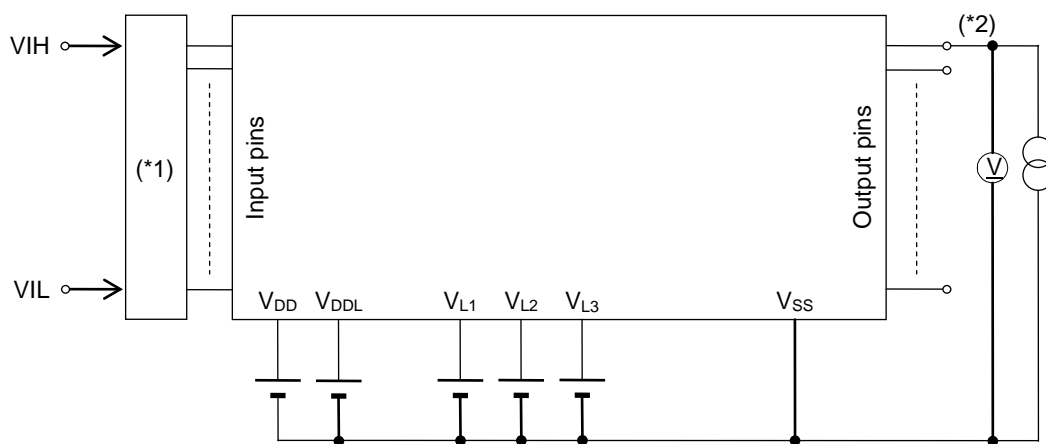
Parameter	Symbol	Condition	Rating			Unit	Measuring circuit
			Min.	Typ.	Max.		
Input voltage 1 (RESET_N) (TEST0, TEST1_N) (P00-P04) (P30-P35) (P40-P47)	VIH1	—	$0.7 \times V_{DD}$	—	V_{DD}	V	5
	VIL1	$V_{DD} = 1.8$ to $3.6V$	0	—	$0.3 \times V_{DD}$		
		$V_{DD} = 1.25$ to $3.6V$	0	—	$0.2 \times V_{DD}$		
Input pin capacitance (P00-P04) (P30-P35) (P40-P47)	CIN	$f = 10kHz$ $V_{rms} = 50mV$ $T_a = 25^{\circ}C$	—	—	5	pF	—

MEASURING CIRCUITS

MEASURING CIRCUIT 1

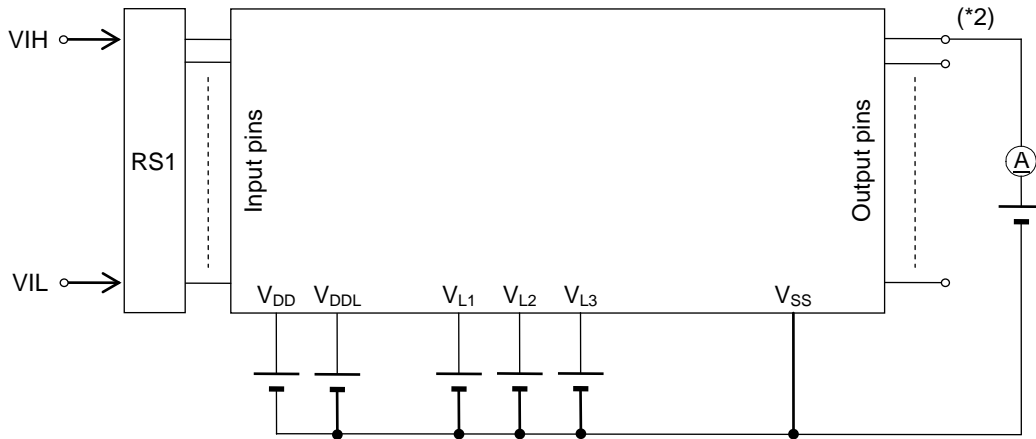


MEASURING CIRCUIT 2



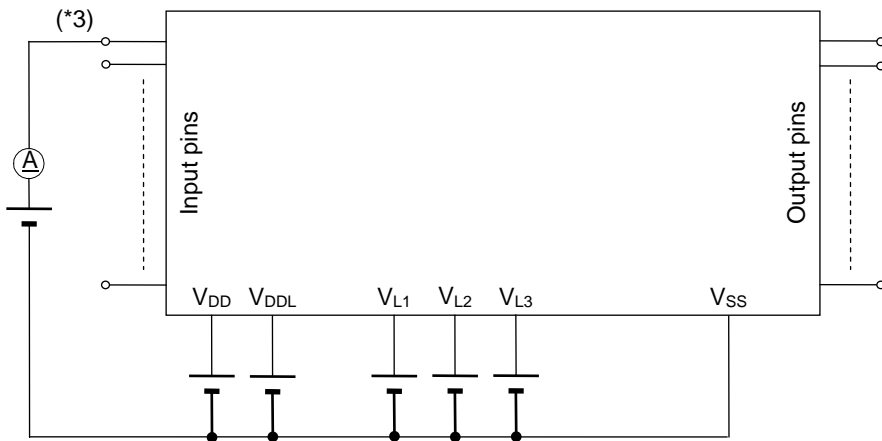
(*1) Input logic circuit to determine the specified measuring conditions.
(*2) Measured at the specified output pins.

MEASURING CIRCUIT 3



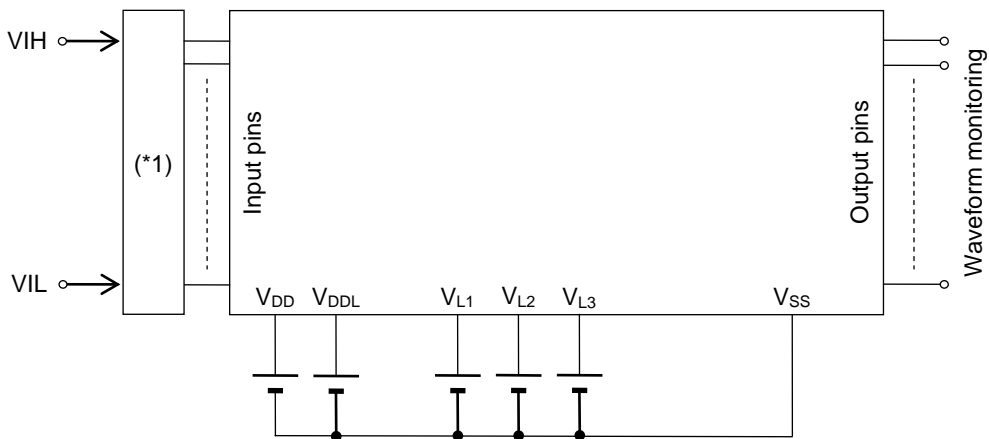
*1: Input logic circuit to determine the specified measuring conditions.
*2: Measured at the specified output pins.

MEASURING CIRCUIT 4



*3: Measured at the specified output pins.

MEASURING CIRCUIT 5

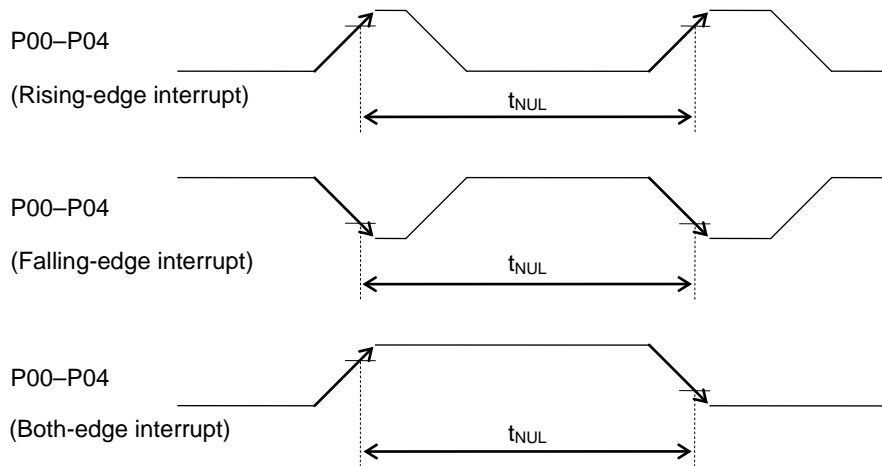


*1: Input logic circuit to determine the specified measuring conditions.

AC CHARACTERISTICS (External Interrupt)

($V_{DD} = 1.25$ to $3.6V$, $V_{SS} = 0V$, $T_a = -20$ to $+70^{\circ}C$, $T_a = -40$ to $+85^{\circ}C$ for P version, unless otherwise specified)

Parameter	Symbol	Condition	Rating			Unit
			Min.	Typ.	Max.	
External interrupt disable period	t_{NUL}	Interrupt: Enabled (MIE = 1), CPU: NOP operation System clock: 32.768kHz	76.8	—	106.8	μs

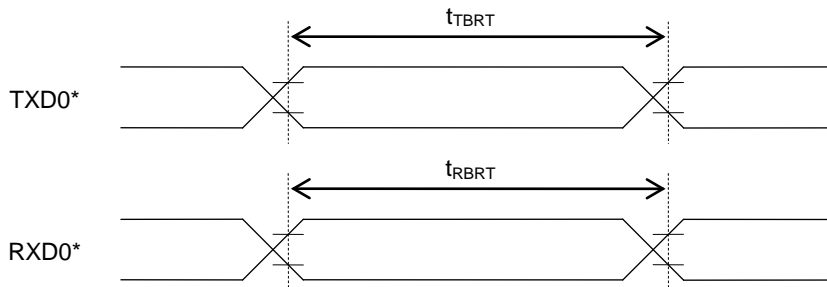


AC CHARACTERISTICS (Serial Port)

($V_{DD} = 1.25$ to $3.6V$, $V_{SS} = 0V$, $T_a = -20$ to $+70^{\circ}C$, $T_a = -40$ to $+85^{\circ}C$ for P version, unless otherwise specified)

Parameter	Symbol	Condition	Rating			Unit
			Min.	Typ.	Max.	
Transmit baud rate	t_{TBRT}	—	—	BRT^{*1}	—	s
Receive baud rate	t_{RBRT}	—	BRT^{*1} -3%	BRT^{*1}	BRT^{*1} +3%	s

*1: Baud rate period (including the error of the clock frequency selected) set with the serial port baud rate register (SIOBRTL,H) and the serial port mode register 0 (SIOMOD0).



*: Indicates the secondary function of the port.

AC CHARACTERISTICS (Synchronous Serial Port)

($V_{DD} = 1.25$ to $3.6V$, $V_{SS} = 0V$, $T_a = -20$ to $+70^\circ C$, $T_a = -40$ to $+85^\circ C$ for P version, unless otherwise specified)

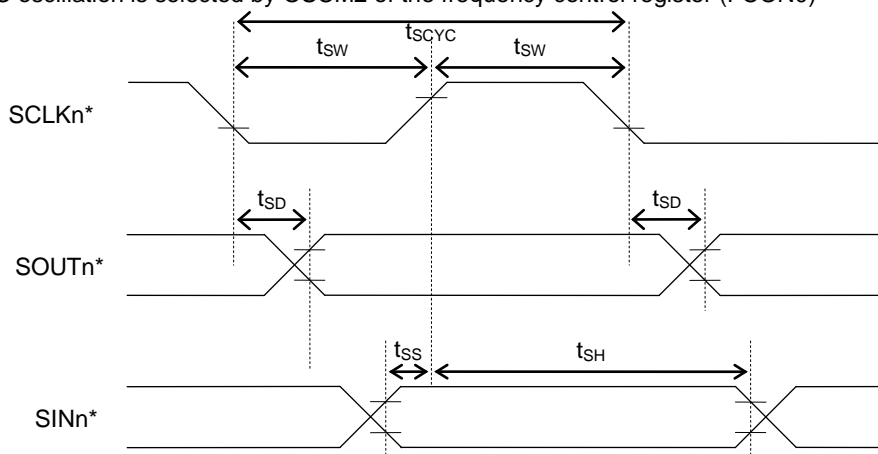
Parameter	Symbol	Condition	Rating			Unit
			Min.	Typ.	Max.	
SCLKn input cycle (slave mode)	t_{SCYC}	When RC oscillation is 500kHz *2 ($V_{DD} = 1.25$ to $3.6V$)	10	—	—	μs
		When RC oscillation is 2MHz *3 ($V_{DD} = 1.8$ to $3.6V$)	2	—	—	
SCLKn output cycle (master mode)	t_{SCYC}	—	—	SCLKn*1	—	s
SCLKn input pulse width (slave mode)	t_{SW}	When RC oscillation is 500kHz *2 ($V_{DD} = 1.25$ to $3.6V$)	4	—	—	μs
		When RC oscillation is 2MHz *3 ($V_{DD} = 1.8$ to $3.6V$)	04	—	—	
SCLKn output pulse width (master mode)	t_{SW}	—	SCLKn*1 $\times 0.4$	SCLKn*1 $\times 0.5$	SCLKn*1 $\times 0.6$	s
SOUTn output delay time (slave mode)	t_{SD}	When RC oscillation is 500kHz *2 ($V_{DD} = 1.25$ to $3.6V$) output load 10pF	—	—	500	ns
		When RC oscillation is 2MHz *3 ($V_{DD} = 1.8$ to $3.6V$) output load 10pF	—	—	240	
SOUTn output delay time (master mode)	t_{SD}	When RC oscillation is 500kHz *2 ($V_{DD} = 1.25$ to $3.6V$) output load 10pF	—	—	500	ns
		When RC oscillation is 2MHz *3 ($V_{DD} = 1.8$ to $3.6V$) output load 10pF	—	—	240	
SINn input setup time (slave mode)	t_{SS}	—	80	—	—	ns
SINn input setup time (master mode)	t_{SS}	When RC oscillation is 500kHz *2 ($V_{DD} = 1.25$ to $3.6V$)	500	—	—	ns
		When RC oscillation is 2MHz *3 ($V_{DD} = 1.8$ to $3.6V$)	240	—	—	
SINn input hold time	t_{SH}	When RC oscillation is 500kHz *2 ($V_{DD} = 1.25$ to $3.6V$)	300	—	—	ns
		When RC oscillation is 2MHz *3 ($V_{DD} = 1.8$ to $3.6V$)	80	—	—	

n = 0, 1

*1: Clock period selected with SnCK3-0 of the serial port n mode register (SIO nMOD1)

*2: When 500kHz RC oscillation is selected by OSCM2 of the frequency control register (FCON0)

*3: When 2MHz RC oscillation is selected by OSCM2 of the frequency control register (FCON0)



*: Indicates the secondary function of the port (n = 0, 1)

AC CHARACTERISTICS (RC Oscillation A/D Converter)

Condition for $V_{DD}=1.8$ to $3.6V$

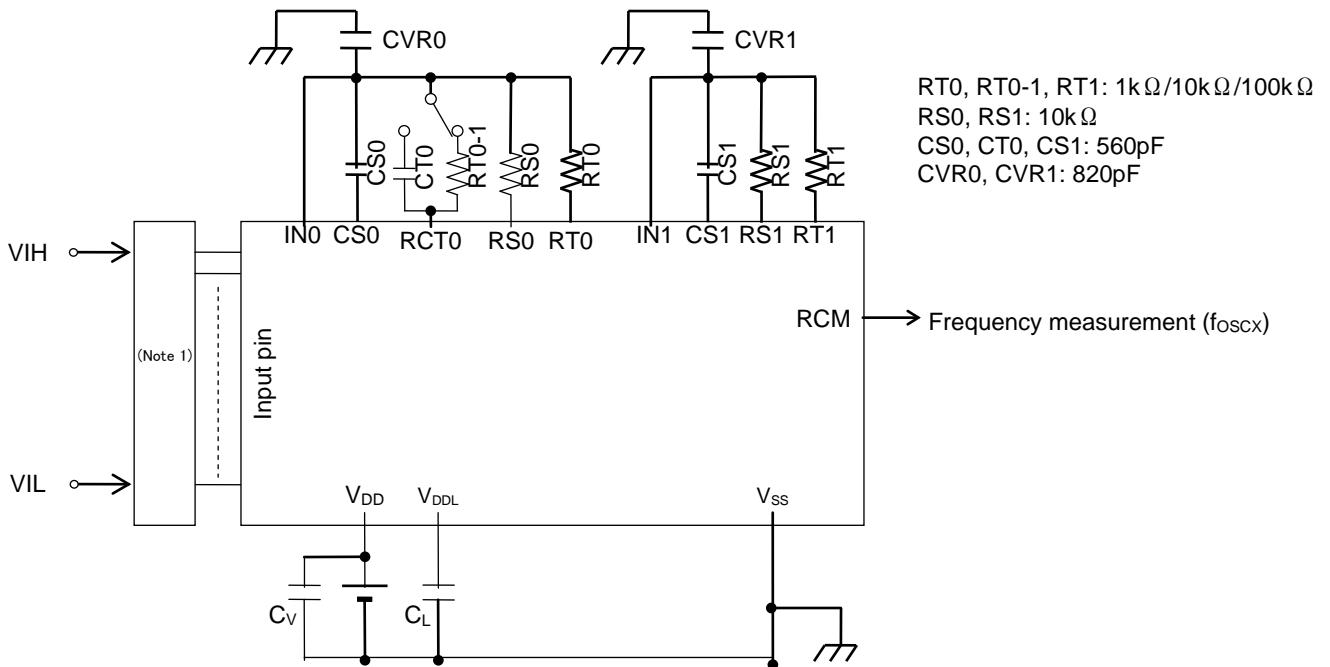
($V_{DD}=1.8$ to $3.6V$, $V_{SS}=0V$, $T_a=-20$ to $+70^{\circ}C$, $T_a=-40$ to $+85^{\circ}C$ for P version, unless otherwise specified)

Parameter	Symbol	Condition	Rating			Unit
			Min.	Typ.	Max.	
Oscillation resistor	RS0,RS1,RT0, RT0-1,RT1	CS0, CT0, CS1 \geq 740pF	1	—	—	k Ω
Oscillation frequency $V_{DD} = 3.0V$	f_{OSC1}	Resistor for oscillation=1k Ω	457.3	525.2	575.1	kHz
	f_{OSC2}	Resistor for oscillation=10k Ω	53.48	58.18	62.43	kHz
	f_{OSC3}	Resistor for oscillation=100k Ω	5.43	5.89	6.32	kHz
RS to RT oscillation frequency ratio ^{*1} $V_{DD} = 3.0V$	Kf1	RT0, RT0-1, RT1 =1k Ω	7.972	9.028	9.782	—
	Kf2	RT0, RT0-1, RT1 =10k Ω	0.981	1	1.019	—
	Kf3	RT0, RT0-1, RT1 =100k Ω	0.099	0.101	0.104	—

*1: Kfx is the ratio of the oscillation frequency by the sensor resistor to the oscillation frequency by the reference resistor on the same conditions.

$$Kfx = \frac{f_{OSCx}(RT0-CS0 \text{ oscillation})}{f_{OSCx}(RS0-CS0 \text{ oscillation})}, \frac{f_{OSCx}(RT0-1-CS0 \text{ oscillation})}{f_{OSCx}(RS0-CS0 \text{ oscillation})}, \frac{f_{OSCx}(RT1-CS1 \text{ oscillation})}{f_{OSCx}(RS1-CS1 \text{ oscillation})}$$

(x = 1, 2, 3)



RT0, RT0-1, RT1: 1k Ω /10k Ω /100k Ω
 RS0, RS1: 10k Ω
 CS0, CT0, CS1: 560pF
 CVR0, CVR1: 820pF

*1: Input logic circuit to determine the specified measuring conditions.

Condition for $V_{DD}=1.25$ to $3.6V$

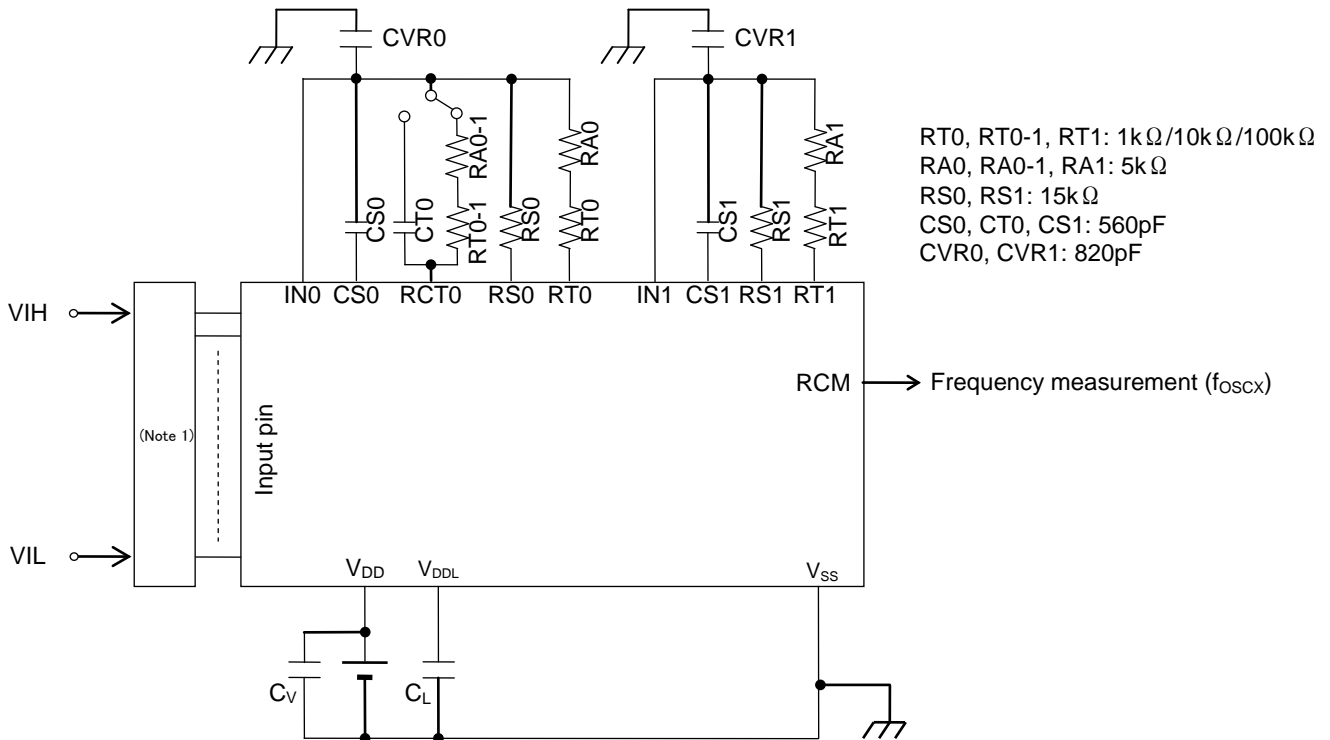
($V_{DD}=1.25$ to $3.6V$, $V_{SS}=0V$, $T_a=-20$ to $+70^{\circ}C$, $T_a=-40$ to $+85^{\circ}C$ for P version, unless otherwise specified)

Parameter	Symbol	Condition	Rating			Unit
			Min.	Typ.	Max.	
Oscillation resistor	RS0,RS1,RT0, RT0-1,RT1	CS0, CT0, CS1 \geq 740pF	1	—	—	k Ω
Oscillation frequency $V_{DD} = 1.5V$	f_{OSC1}	Resistor for oscillation=6k Ω	81.93	93.16	101.2	kHz
	f_{OSC2}	Resistor for oscillation=15k Ω	35.32	38.75	41.48	kHz
	f_{OSC3}	Resistor for oscillation=105k Ω	5.22	5.65	6.03	kHz
RS to RT oscillation frequency ratio ^{*1} $V_{DD} = 1.5V$	Kf1	RT0, RT0-1, RT1 =1k Ω	2.139	2.381	2.632	—
	Kf2	RT0, RT0-1, RT1 =10k Ω	0.973	1	1.028	—
	Kf3	RT0, RT0-1, RT1 =100k Ω	0.142	0.147	0.152	—
Oscillation frequency $V_{DD} = 3.0V$	f_{OSC1}	Resistor for oscillation=6k Ω	85.28	94.58	103.3	kHz
	f_{OSC2}	Resistor for oscillation=15k Ω	35.72	38.87	41.78	kHz
	f_{OSC3}	Resistor for oscillation=105k Ω	5.189	5.622	6.012	kHz
RS to RT oscillation frequency ratio ^{*1} $V_{DD} = 3.0V$	Kf1	RT0, RT0-1, RT1 =1k Ω	2.227	2.432	2.626	—
	Kf2	RT0, RT0-1, RT1 =10k Ω	0.982	1	1.018	—
	Kf3	RT0, RT0-1, RT1 =100k Ω	0.141	0.145	0.149	—

*1: Kfx is the ratio of the oscillation frequency by the sensor resistor to the oscillation frequency by the reference resistor on the same conditions.

$$Kfx = \frac{f_{OSCx}(RT0-CS0 \text{ oscillation})}{f_{OSCx}(RS0-CS0 \text{ oscillation})}, \frac{f_{OSCx}(RT0-1-CS0 \text{ oscillation})}{f_{OSCx}(RS0-CS0 \text{ oscillation})}, \frac{f_{OSCx}(RT1-CS1 \text{ oscillation})}{f_{OSCx}(RS1-CS1 \text{ oscillation})}$$

(x = 1, 2, 3)



*1: Input logic circuit to determine the specified measuring conditions.

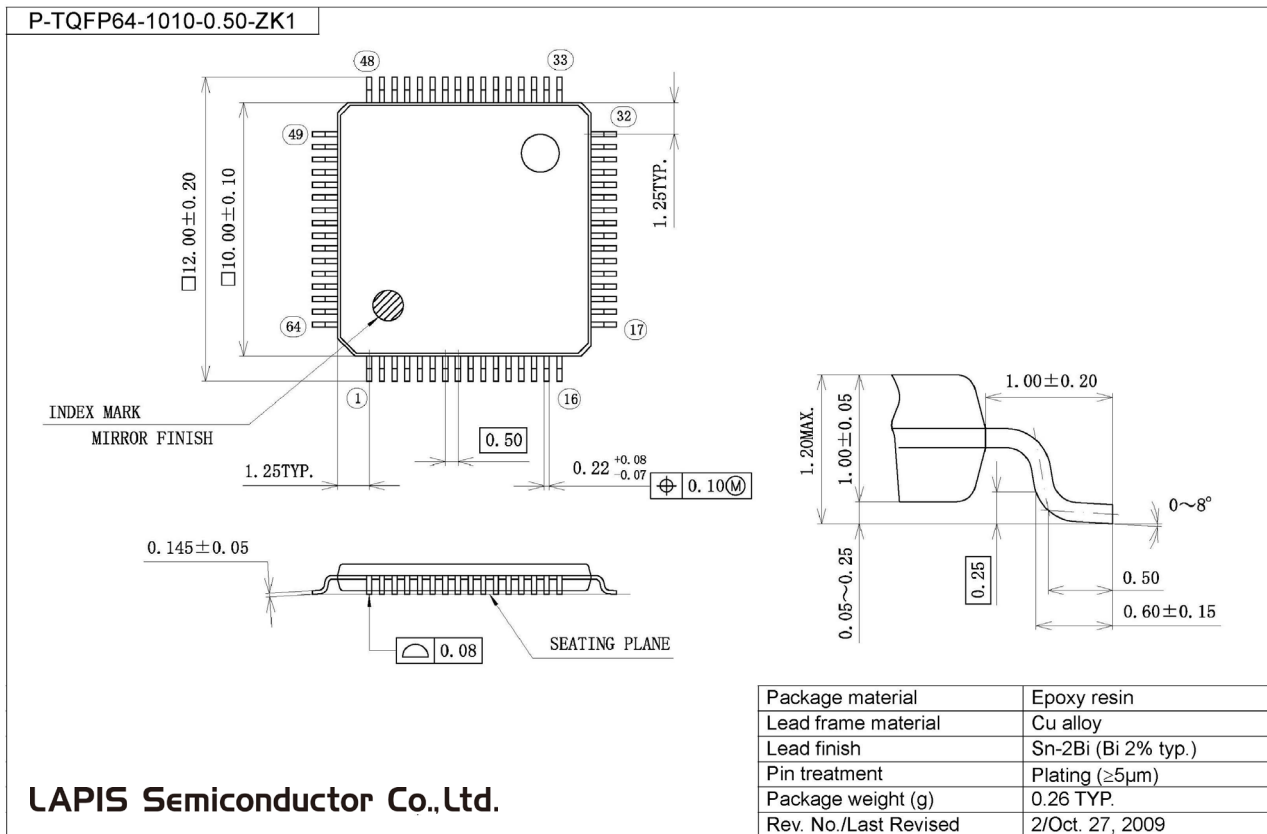
Note:

- Please have the shortest layout for the common node (wiring patterns which are connected to the external capacitors, resistors and IN0/IN1 pin), including CVR0/CVR1. Especially, do not have long wire between IN0/IN1 and RS0/RS1. The coupling capacitance on the wires may occur incorrect A/D conversion. Also, please do not have signals which may be a source of noise around the node.
- When RT0/RT1 (Thermistor and etc.) requires long wiring due to the restricted placement, please have VSS(GND) trace next to the signal.

- Please make wiring to components (capacitor, resistor and etc.) necessary for objective measurement. Wiring to reserved components may affect to the A/D conversion operation by noise the components itself may have.

Package Dimensions

(Unit : mm)



Notes for Mounting the Surface Mount Type Package

The surface mount type packages are very susceptible to heat in reflow mounting and humidity absorbed in storage. Therefore, before you perform reflow mounting, contact our responsible sales person for the product name, package name, pin number, package code and desired mounting conditions (reflow method, temperature and times).

Revision History

Document No.	Date	Page		Description
		Previous Edition	Current Edition	
FEDL610Q461-01	Oct.10,2013	-	-	Final edition 1

NOTES

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